

N-Channel 20-V (D-S) MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	$R_{DS(on)}$ (Ω)(Typ)	I _D (A) ^{a, e}	Q _g (Typ)		
20	2.2 at V _{GS} = 4.5 V	80	90 nC		
	3.0 at V _{GS} = 2.5 V	70	30110		

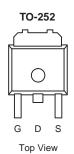
FEATURES

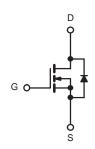
- **DT-Trench Power MOSFET**
- 100 % R_g and UIS Tested
- Compliant to RoHS Directive 2011/65/EU



APPLICATIONS

- **OR-ing**
- Server
- DC/DC





N-Channel MOSFET

Parameter		Symbol	Limit	Unit	
Drain-Source Voltage	V _{DS}	20	V		
Gate-Source Voltage	V _{GS}	± 12	¬		
	T _C = 25 °C		80 ^{a, e}		
Continuous Drain Current (T _{.I} = 175 °C)	T _C = 70 °C	1-	65 ^e		
Continuous Diam Current (1j = 175 C)	T _A = 25 °C	I _D	20.5 ^{b, c}	A	
	T _A = 70 °C		12 ^{b, c}		
Pulsed Drain Current		I _{DM}	320	7	
Avalanche Current Pulse	L = 0.1 mH	I _{AS}	75		
Single Pulse Avalanche Energy	L = 0.1 IIII	E _{AS}	189	mJ	
Continuous Source-Drain Diode Current	T _C = 25 °C	la la	80 ^{a, e}	Α Α	
Continuous Source-Diam blode Current	T _A = 25 °C	I _S	20.5 ^{b, c}		
Maximum Power Dissipation	T _C = 25 °C		105 ^a		
	T _C = 70 °C	PD	67	W	
	T _A = 25 °C	' D	2.55 ^{b, c}	VV	
	T _A = 70 °C		1.61 ^{b, c}		
Operating Junction and Storage Temperature Ra	T _J , T _{stg}	- 55 to 175	°C		

THERMAL RESISTANCE RATINGS							
Parameter	Symbol	Тур.	Max.	Unit			
Maximum Junction-to-Ambient ^{b, d}	t ≤ 10 sec	R_{thJA}	15	25	°C/W		
Maximum Junction-to-Case	Steady State	R _{thJC}	0.8	1.5	C/VV		

- a. Based on T_C = 25 °C.
 b. Surface mounted on 1" x 1" FR4 board.

- c. t = 10 sec.
 d. Maximum under steady state conditions is 90 °C/W.
 e. Calculated based on maximum junction temperature.



Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static							
Drain-Source Breakdown Voltage	V_{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	20			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$ $I_{D} = 250 \mu A$			35		mV/°C	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_{J}$	10 = 200 μΛ		- 7.5		mv/·C	
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	0.5		1.0	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 12 \text{ V}$			± 100	nA	
Zana Oata Wallana Basia Oamasi	I _{DSS}	V _{DS} = 16 V, V _{GS} = 0 V			1		
Zero Gate Voltage Drain Current		V _{DS} = 16 V, V _{GS} = 0 V, T _J = 55 °C			10	μA	
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, V_{GS} = 4.5 \text{ V}$	80			Α	
Drain-Source On-State Resistance ^a	R _{DS(on)}	$V_{GS} = 4.5 \text{ V}, I_D = 30 \text{ A}$		2.2	2.8	mC	
		$V_{GS} = 2.5 \text{ V}, I_D = 20 \text{ A}$		3	4	mΩ	
Forward Transconductance ^a	9 _{fs}	V _{DS} = 5 V, I _D = 20 A		105		S	
Dynamic ^b					•	•	
Input Capacitance	C _{iss}			6680		pF	
Output Capacitance	C _{oss}	$V_{DS} = 10 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		1160			
Reverse Transfer Capacitance	C _{rss}			330			
Total Gate Charge	Qg			105		nC	
Gate-Source Charge	Q _{gs}	$V_{DS} = 10 \text{ V}, V_{GS} = 4.5 \text{ V}, I_D = 30 \text{ A}$		32			
Gate-Drain Charge	Q _{gd}			21			
Gate Resistance	R _g	f = 1 MHz		1.5		Ω	
Turn-On Delay Time	t _{d(on)}			21			
Rise Time	t _r	$V_{DD} = 10 \text{ V}, R_{L} = 0.625 \Omega$		15		ns	
Turn-Off Delay Time	t _{d(off)}	$I_{D} \cong 30 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$		77			
Fall Time	t _f			13			
Drain-Source Body Diode Characteristic	s	,		_	<u>'</u>	•	
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			80	A	
Pulse Diode Forward Current ^a	I _{SM}				320		
Body Diode Voltage	V _{SD}	I _S = 30 A		0.8	1.2	V	
Body Diode Reverse Recovery Time	t _{rr}	t _{rr}		55		ns	
Body Diode Reverse Recovery Charge Q		1 - 20 A di/dt - 100 A/::: T 25 °C		73		nC	
Reverse Recovery Fall Time	t _a	$I_F = 30 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 \text{ °C}$		27		1	
Reverse Recovery Rise Time		t _b		29		ns	

Notes:

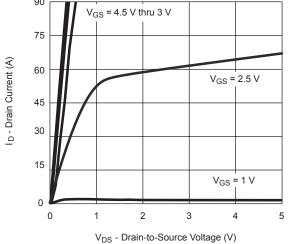
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

a. Pulse test; pulse width $\leq 300~\mu\text{s},$ duty cycle $\leq 2~\%.$

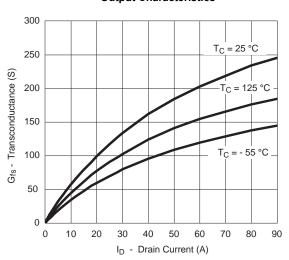
b. Guaranteed by design, not subject to production testing.



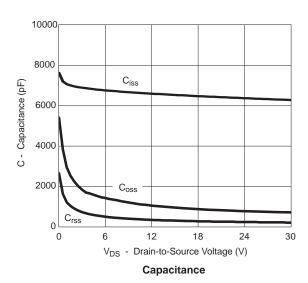
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

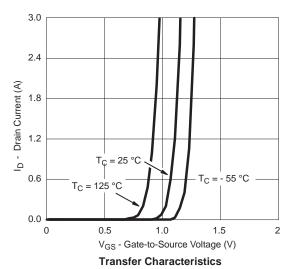


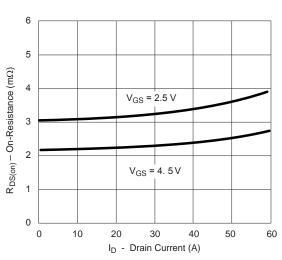
Output Characteristics



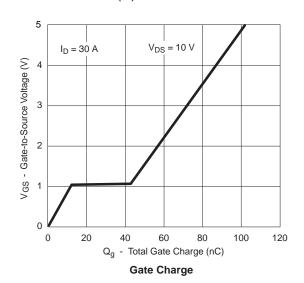
Transconductance





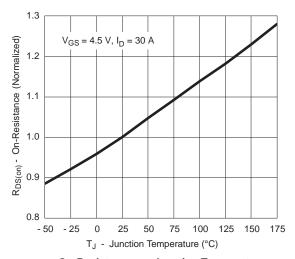


R_{DS(on)} vs. Drain Current

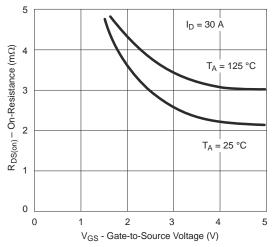




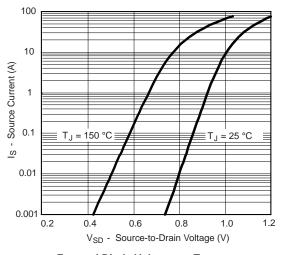
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



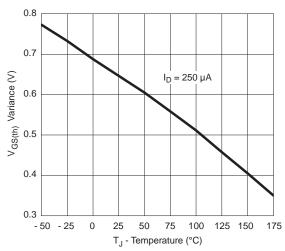
On-Resistance vs. Junction Temperature



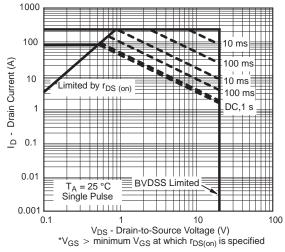
 $R_{DS(on)}$ vs. V_{GS} vs. Temperature



Forward Diode Voltage vs. Temperature

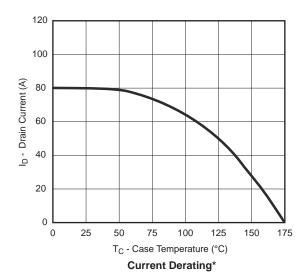


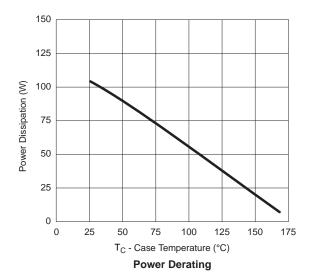
Threshold Voltage



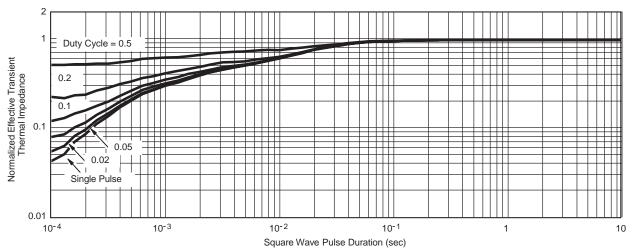
Safe Operating Area, Junction-to-Ambient

TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)





*The power dissipation P_D is based on $T_{J(max)} = 175$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit



Normalized Thermal Transient Impedance, Junction-to-Case





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